

Application No.	Applicant(s)	
09/966,967	JIANG ET AL.	
Examiner	Art Unit	
Tan V Mai	2124	

SEARCHED				
Class	Subclass	Date	Examiner	
708	250,252, 256	7/28/2004	men	
380	46	V	V	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
708	252	7/28/2004	Wen	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Double Patenting Check Data Bases Search (see attached copy)	7/28/2004	Ne

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